


<b>Search Notes</b>  	<b>Application/Control No.</b>  10791967	<b>Applicant(s)/Patent Under Reexamination</b>  TALUKDAR ET AL.
	<b>Examiner</b>  Hanh Nguyen	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
709	231	10/8/08	hn
709	219		
709	218		
709	225		
709	203		
714	4		
714	724		
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370	242		
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370	252		
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707	102	10/8/08	hn

SEARCH NOTES			
Search Notes		Date	Examiner
east		10/8/08	hn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	230.1	10/8/08	hn
370	465		
370	412		
370	389		
709	227		
709	232	10/8/08	hn

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